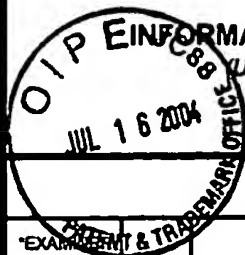


IDS - 12/09/2003 **ELECTRONIC INFORMATION DISCLOSURE STATEMENT**

Electronic Version v18

Stylesheet Version v18.0

Title of Invention	SCAN CHAIN DIAGNOSTICS USING LOGIC PATHS						
<p>Application Number : 10/707 373</p> <p>Confirmation Number: .</p> <p>First Named Applicant: Leendert Huisman</p> <p>Attorney Docket Number: BUR920030139US1</p> <p>Art Unit: 2138</p> <p>Examiner: BRITT</p> <p>Search string: (6308290).pn</p>							
US Patent Documents							
Note: Applicant is not required to submit a paper copy of cited US Patent Documents							
init	Cite.No.	Patent No.	Date	Patentee	Kind	Class	Subclass
CB	1	6308290	2001-10-23	Forlenza et al.		714	724
Signature							
Examiner Name				Date			
/Cynthia Britt/				07/18/2006			



INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

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BUR920030139US1

SERIAL NO.

10/707373

Leendert M. Huisman et al.

FILING

12/09/2003

GROUP

2138

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE

FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

CB		Schafer et al., PARTNER SRLS FOR IMPROVED SHIFT REGISTER DIAGNOSTICS, IEEE VLSI Test Symposium 1992, pages 198-201.

EXAMINER

/Cynthia Britt/

DATE CONSIDERED

07/18/2006

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.